

Notice of References Cited	Application/Control No. 10/785,402	Applicant(s)/Patent Under Reexamination JUNG, HEE-WON	
	Examiner John L. Goodrow	Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,723,822	04-2004	Shirai et al.	528/195
	B	US-6,350,822	02-2002	Van Diepen et al.	525/444
	C	US-6,194,115	02-2001	Nagase et al.	430/109.4
	D	US-6,136,488	10-2000	Kushino et al.	430/108.21
	E	US-5,795,691	08-1998	Yamazaki et al.	430/111.35
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.